

# MBN1600E17F

Silicon N-channel IGBT 1700V F version

## FEATURES

- \* Soft switching behavior & low conduction loss:  
Soft low-injection punch-through with trench gate IGBT.
- \* Low driving power:  
Low input capacitance advanced trench gate.
- \* Ultra soft fast recovery diode.

## ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub>=25°C)

Item	Symbol	Unit	MBN1600E17F
Collector Emitter Voltage	V <sub>CES</sub>	V	1,700
Gate Emitter Voltage	V <sub>GES</sub>	V	±20
Collector Current	DC	I <sub>c</sub>	1,600
	1ms	I <sub>cp</sub>	3,200
Forward Current	DC	I <sub>F</sub>	1,600
	1ms	I <sub>FM</sub>	3,200
Junction Temperature	T <sub>j op</sub>	°C	-50 ~ +150
Storage Temperature	T <sub>stg</sub>	°C	-40 ~ +125
Isolation Voltage	V <sub>ISO</sub>	V <sub>RMS</sub>	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value  $1.8 \pm 0.2/15^{+0}_{-3}$  N·m (2) Recommended Value  $5.5 \pm 0.5$  N·m

## ELECTRICAL CHARACTERISTICS

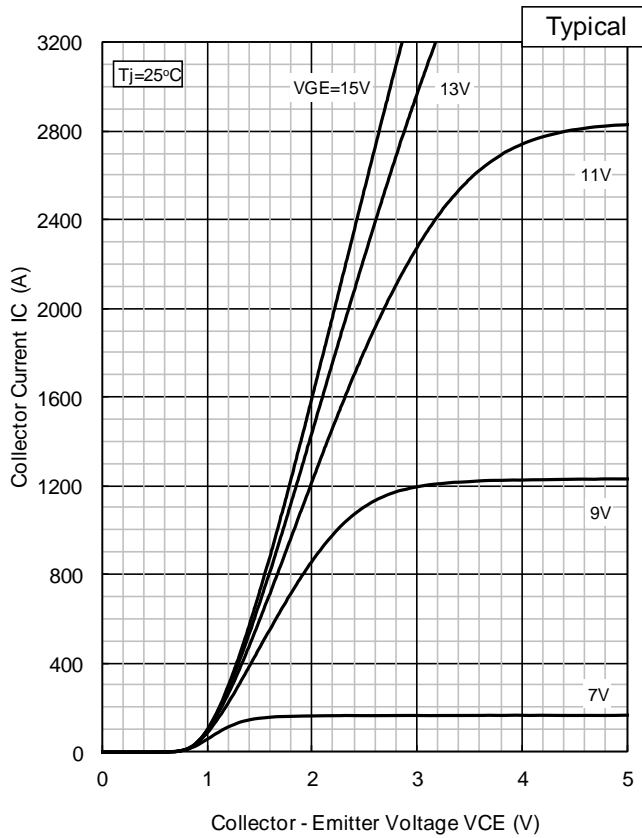
Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I <sub>CES</sub>	mA	-	5	-	V <sub>CE</sub> =1,700V, V <sub>GE</sub> =0V, T <sub>j</sub> =25°C
			-	20	80	V <sub>CE</sub> =1,700V, V <sub>GE</sub> =0V, T <sub>j</sub> =150°C
Gate Emitter Leakage Current	I <sub>GES</sub>	nA	-500	-	+500	V <sub>GE</sub> =±20V, V <sub>CE</sub> =0V, T <sub>j</sub> =25°C
Collector Emitter Saturation Voltage	V <sub>CE(sat)</sub>	V	-	2.0	-	I <sub>c</sub> =1,600A, V <sub>GE</sub> =15V, T <sub>j</sub> =25°C
			1.9	2.4	2.8	I <sub>c</sub> =1,600A, V <sub>GE</sub> =15V, T <sub>j</sub> =150°C
Gate Emitter Threshold Voltage	V <sub>GE(TO)</sub>	V	4.1	5.5	7.1	V <sub>CE</sub> =10V, I <sub>c</sub> =160mA, T <sub>j</sub> =25°C
Input Capacitance	C <sub>ies</sub>	nF	-	87	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>j</sub> =25°C
Internal Gate Resistance	R <sub>ge</sub>	Ω	-	2.3	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>j</sub> =25°C
Switching Times	Rise Time	t <sub>r</sub>	-	0.4	0.8	V <sub>CC</sub> =900V, I <sub>c</sub> =1,600A
	Turn On Time	t <sub>on</sub>	-	1.0	2.0	L <sub>s</sub> =65nH (3)
	Fall Time	t <sub>f</sub>	-	1.4	2.8	R <sub>G</sub> (on/off)=3.9Ω/3.9Ω (3)
	Turn Off Time	t <sub>off</sub>	-	3.2	6.4	V <sub>GE</sub> =±15V, T <sub>j</sub> =150°C
Peak Forward Voltage Drop	V <sub>FM</sub>	V	-	1.8	-	I <sub>F</sub> =1,600A, V <sub>GE</sub> =0V, T <sub>j</sub> =25°C
			1.3	2.0	2.7	I <sub>F</sub> =1,600A, V <sub>GE</sub> =0V, T <sub>j</sub> =150°C
Reverse Recovery Time	t <sub>rr</sub>	μs	-	0.65	1.3	
Turn On Loss	E <sub>on</sub>	J/P	-	0.6	-	V <sub>CC</sub> =900V, I <sub>c</sub> =1,600A L <sub>s</sub> =65nH (3)
Turn Off Loss	E <sub>off</sub>	J/P	-	1.3	-	R <sub>G</sub> (on/off)= 3.9Ω/3.9Ω (3) V <sub>GE</sub> =±15V, T <sub>j</sub> =150°C
Reverse Recovery Loss	E <sub>rr</sub>	J/P	-	0.85	-	
Stray inductance in module	L <sub>SCE</sub>	nH	-	18	-	
Thermal Impedance	IGBT	R <sub>th(j-c)</sub>	-	-	0.015	Junction to case
	FWD	R <sub>th(j-c)</sub>	-	-	0.023	
Contact Thermal Impedance	R <sub>th(c-f)</sub>	K/W	-	0.008	-	Case to fin (λ.grease=1W/(m·K), heat-sink flatness ≤50μm)

Notes:(3) L<sub>s</sub> and R<sub>G</sub> are the test condition's values for evaluation of the switching times, not recommended value.  
Please, determine the suitable R<sub>G</sub> value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

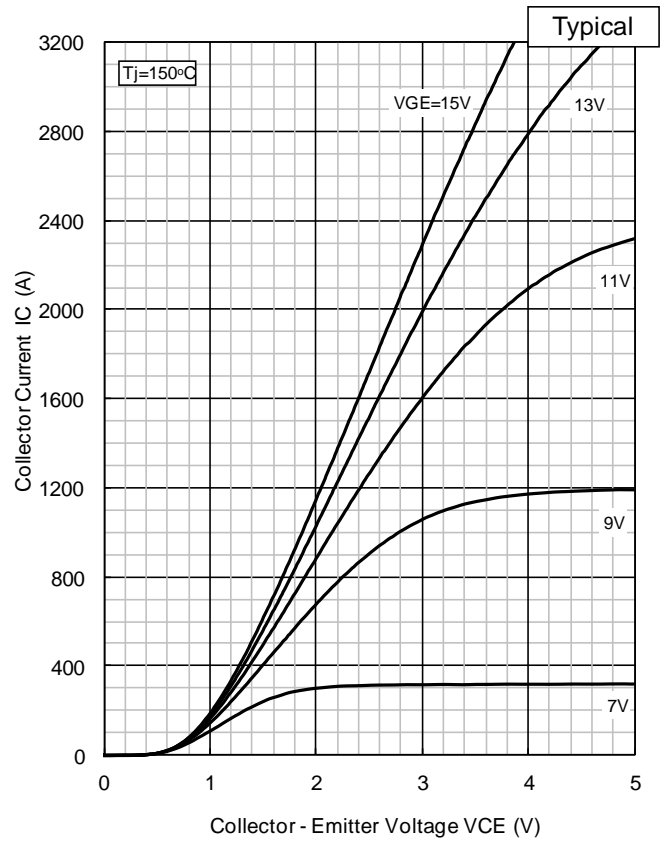
- \* Please contact our representatives at order.
- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.
- \* ELECTRIC CHARACTERISTICS values are according to IEC 60747-2 and IEC 60747-9.

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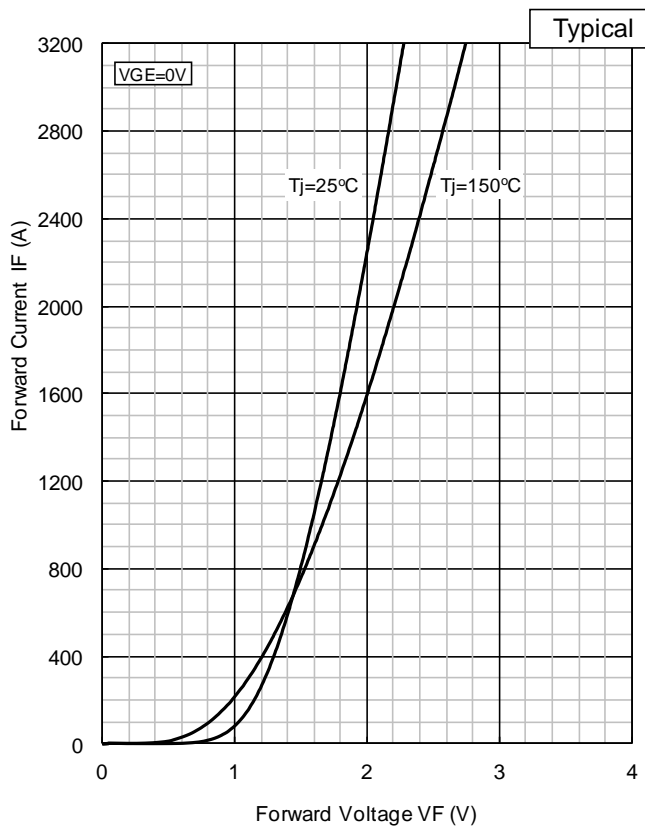
## STATIC CHARACTERISTICS



**$I_C$  vs.  $V_{CE}$  ( $T_j=25^\circ\text{C}$ )**



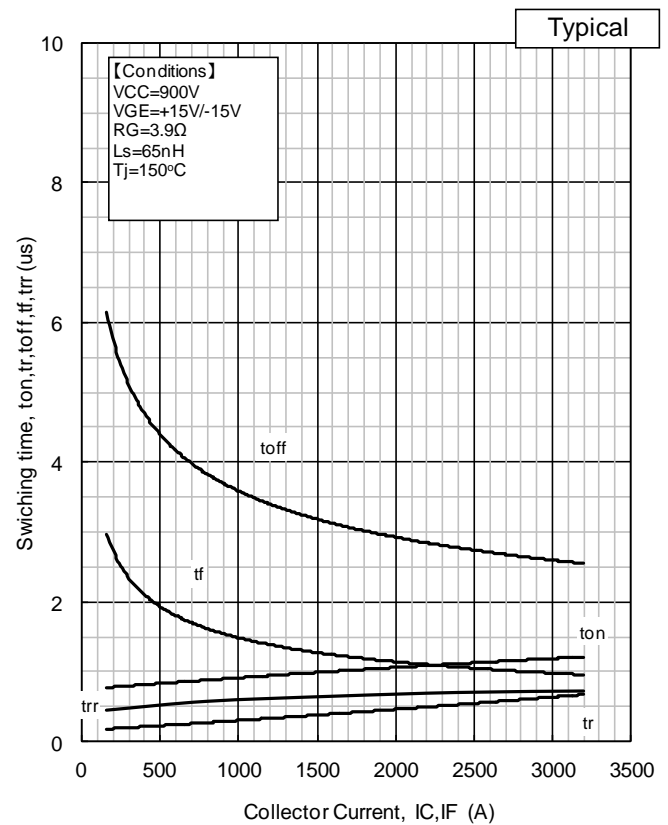
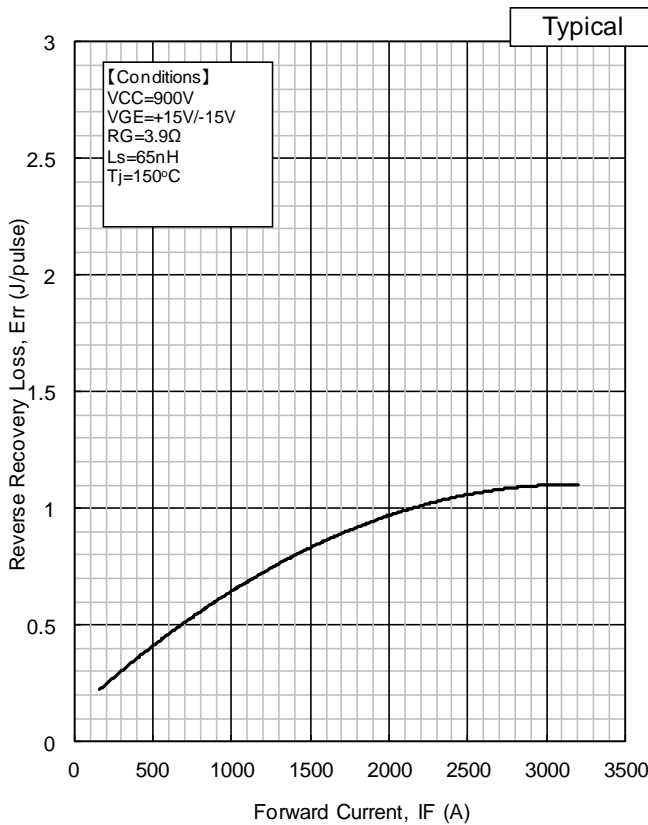
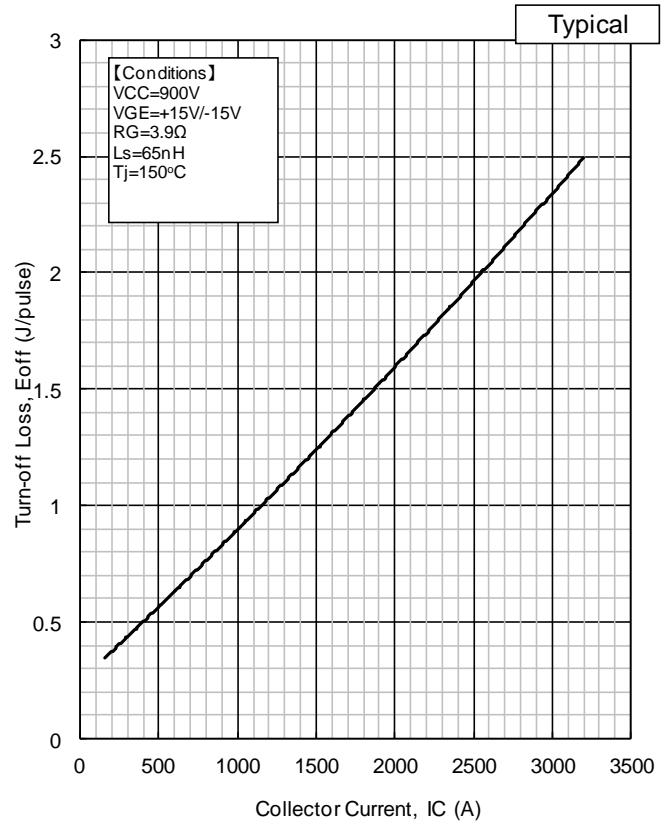
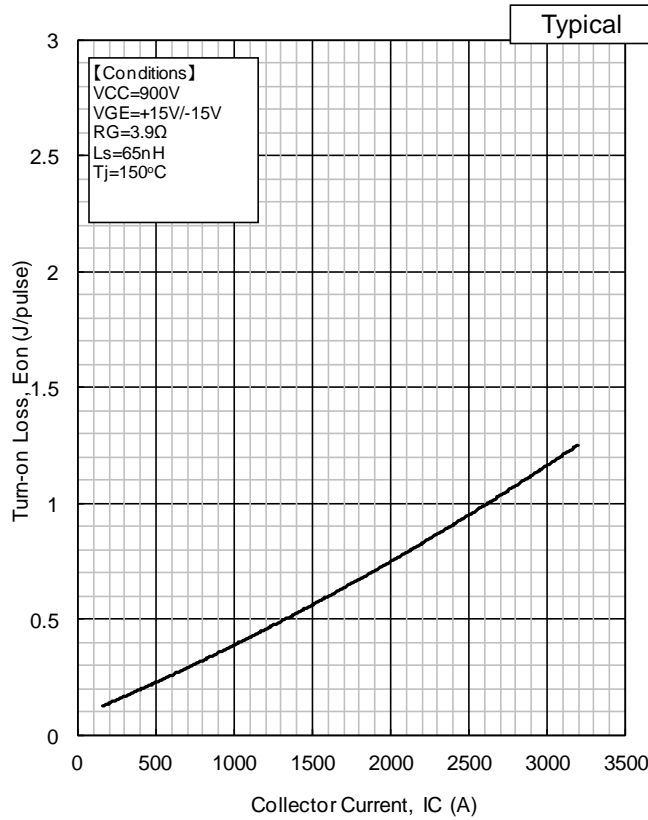
**$I_C$  vs.  $V_{CE}$  ( $T_j=150^\circ\text{C}$ )**



**$I_F$  vs.  $V_F$**

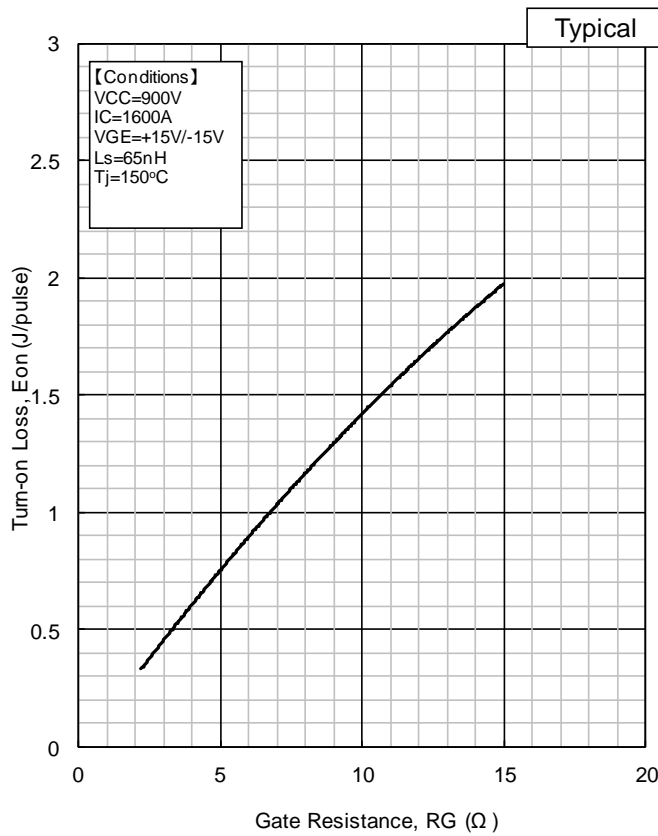
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## DYNAMIC CHARACTERISTICS

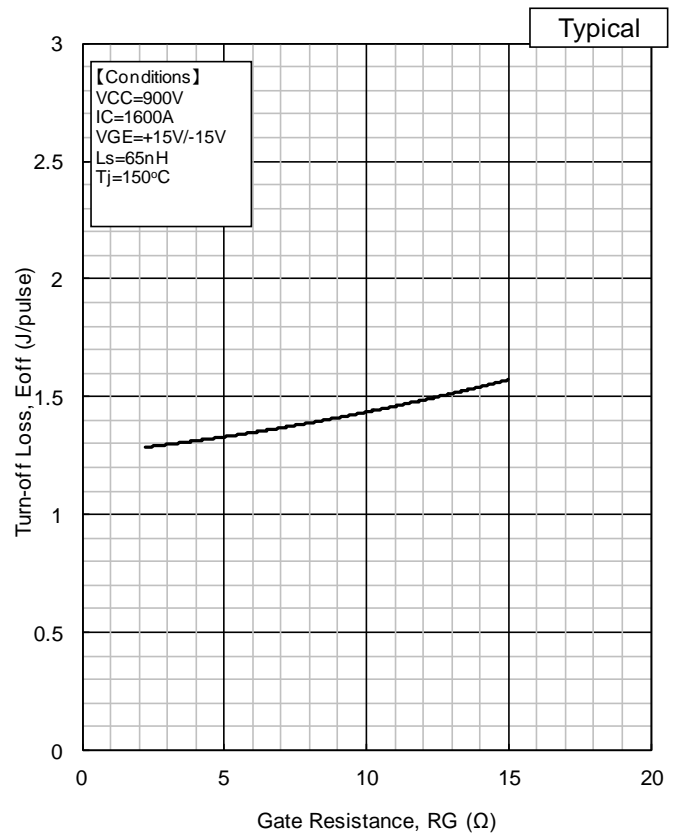


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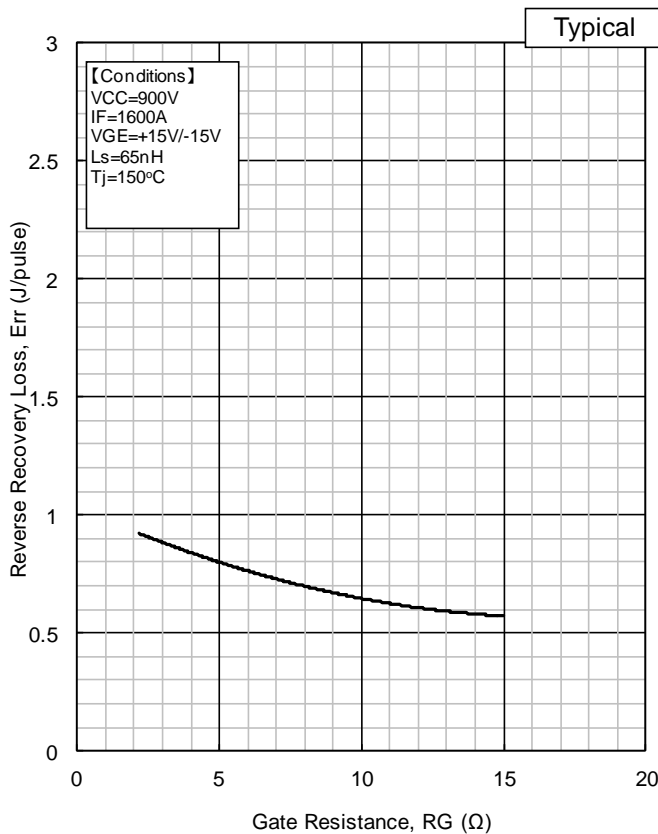
## DYNAMIC CHARACTERISTICS



Turn-on loss vs. Gate Resistance

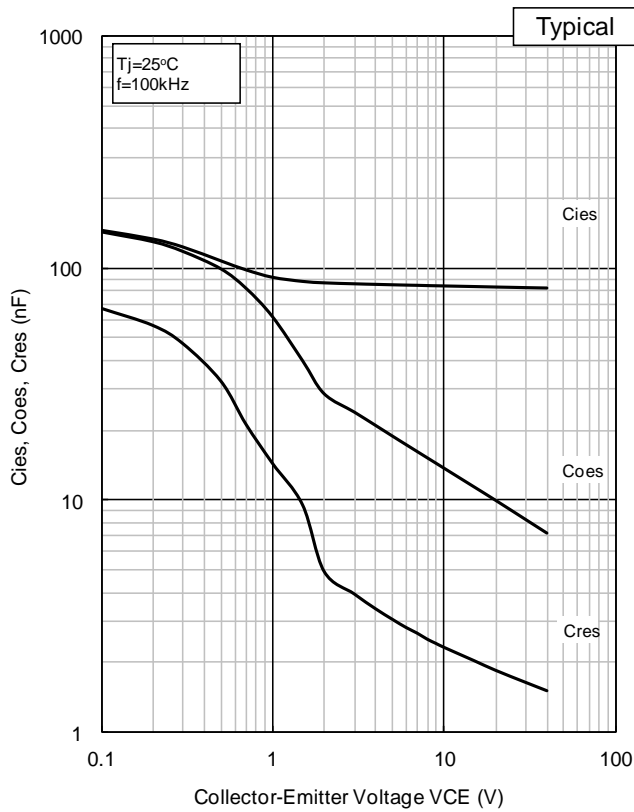


Turn-off loss vs. Gate Resistance

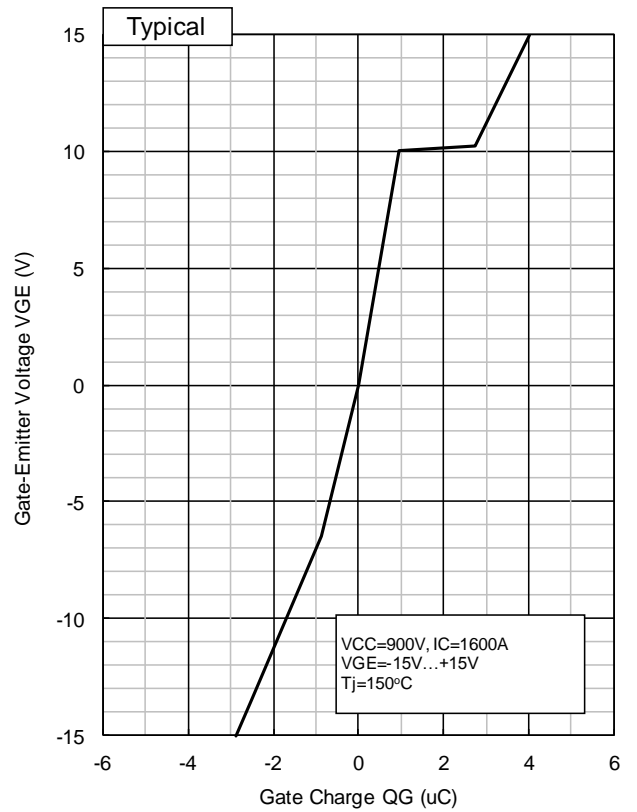


Recovery loss vs. Gate Resistance

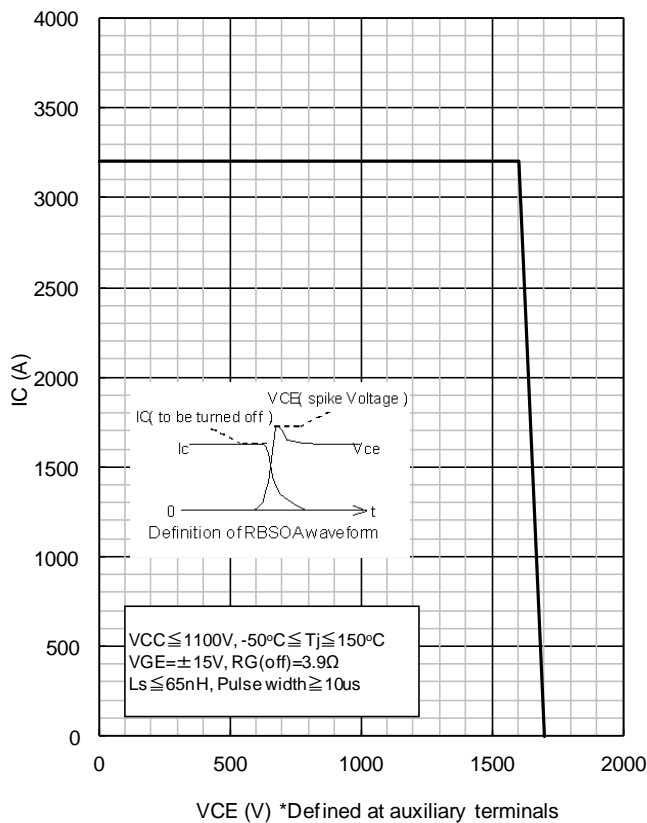
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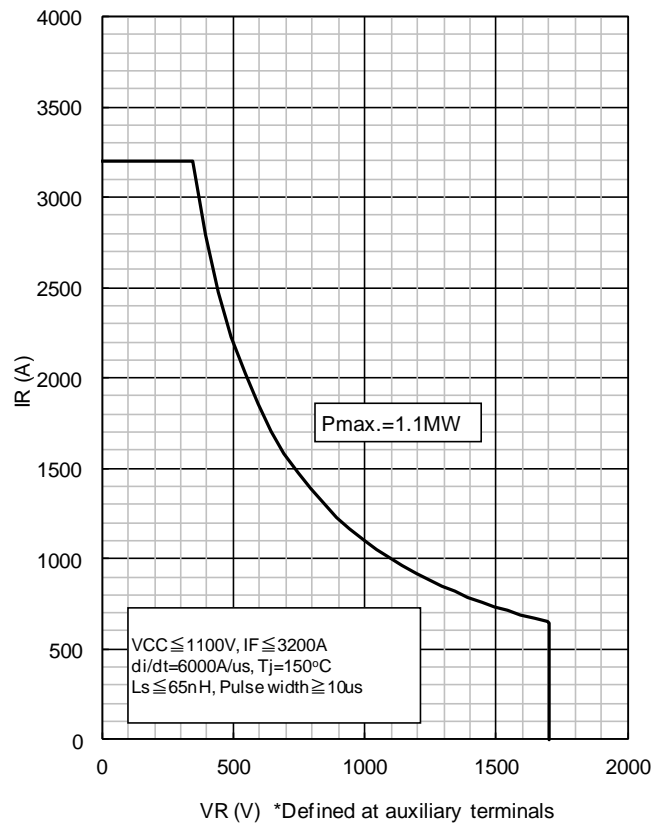
**Cies, Coes, Cres - VCE**



**QG - VGE**



**RBSOA**

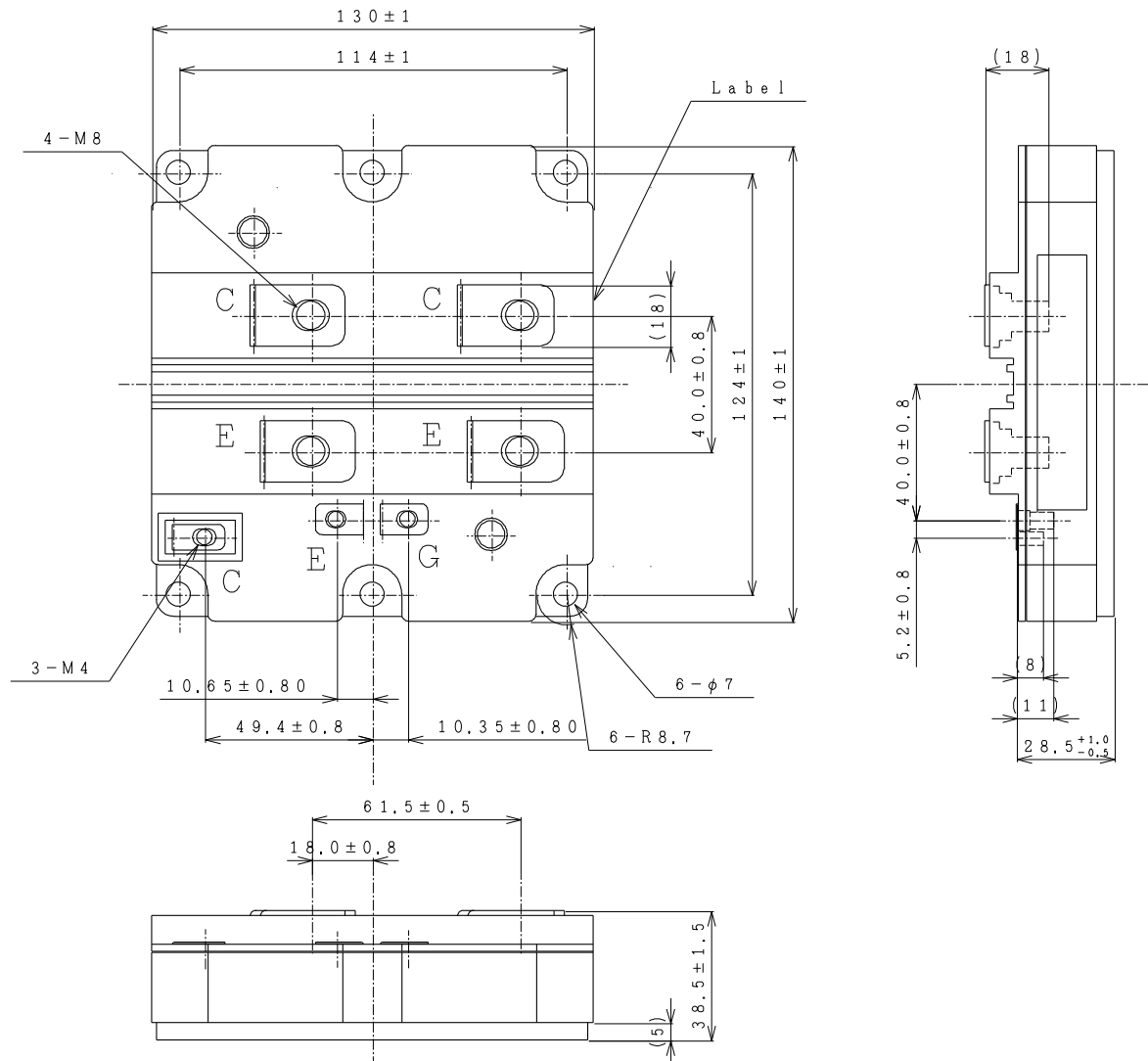


**RecSOA**

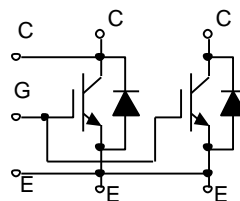
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## Outline Drawing

Unit in mm



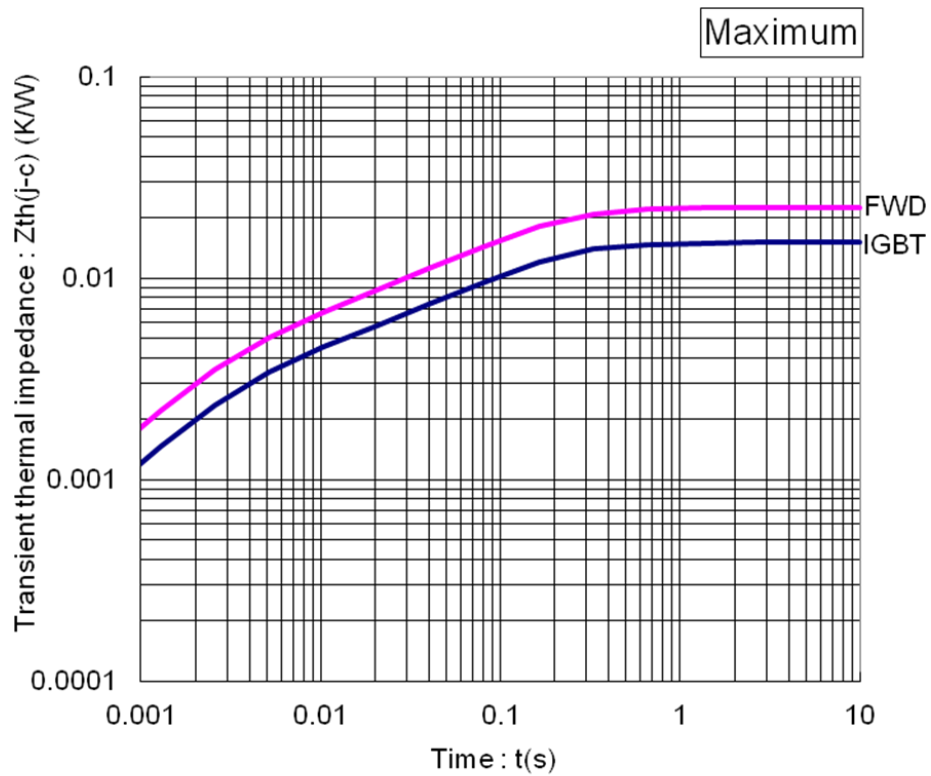
Weight: 900g



Circuit Diagram

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## TRANSIENT THERMAL IMPEDANCE



Transient Thermal Impedance Curve

### Curve Approximation Model

$$\sum r_{th}[n] * (1 - \exp(-t/\tau_{th}[n]))$$

n	1	2	3	4	Unit
$\tau_{th}[n]$	1.50E-01	2.58E-02	3.09E-03	5.61E-04	sec
$r_{th}[n,IGBT]$	8.97E-03	2.93E-03	2.70E-03	3.97E-04	K/W
$r_{th}[n,Diode]$	1.36E-02	4.73E-03	4.01E-03	6.26E-04	K/W

### Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

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## HITACHI POWER SEMICONDUCTORS

### Notices

1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
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